

Search Notes

Application/Control No.

10/021,224

Examiner

Alvin H. Tan

Applicant(s)/Patent under
Reexamination

AN CHANG ET AL.

Art Unit

2173

SEARCHED

Class	Subclass	Date	Examiner
715	757, 764, 765, 782, 810, 836	11/1/2005	AT
715	848, 849	11/1/2005	AT
715	852, 853	11/1/2005	AT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	11/1/2005	AT